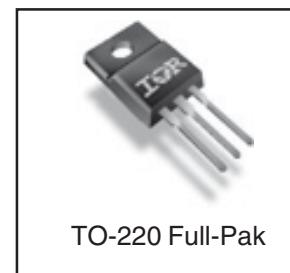


**SMPS MOSFET**

**IRFIB7N50LPbF**

HEXFET® Power MOSFET

| <b>V<sub>DSS</sub></b> | <b>R<sub>DS(on)</sub> typ.</b> | <b>T<sub>rr</sub> typ.</b> | <b>I<sub>D</sub></b> |
|------------------------|--------------------------------|----------------------------|----------------------|
| 500V                   | 320mΩ                          | 85ns                       | 6.8A                 |



**Applications**

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control applications
- Lead-Free

**Features and Benefits**

- SuperFast body diode eliminates the need for external diodes in ZVS applications.
- Lower Gate charge results in simpler drive requirements.
- Enhanced dv/dt capabilities offer improved ruggedness.
- Higher Gate voltage threshold offers improved noise immunity.

**Absolute Maximum Ratings**

|   | Parameter                                       | Max.                   |  | Units |  |
|---|---|------------------------|--|-------|--|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V | 6.8                    |  | A     |  |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V |                        |  |       |  |
| I <sub>DM</sub>                         | Pulsed Drain Current ①                          | 27                     |  |       |  |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C  | Power Dissipation                               | 46                     |  | W     |  |
|   | Linear Derating Factor                          | 0.37                   |  | W/°C  |  |
| V <sub>GS</sub>                         | Gate-to-Source Voltage                          | ±30                    |  | V     |  |
| dv/dt                                   | Peak Diode Recovery dv/dt ③                     | 24                     |  | V/ns  |  |
| T <sub>J</sub>                          | Operating Junction and                          | -55 to + 150           |  | °C    |  |
| T <sub>STG</sub>                        | Storage Temperature Range                       |                        |  |       |  |
|   | Soldering Temperature, for 10 seconds           | 300 (1.6mm from case ) |  |       |  |
|   | Mounting torque, 6-32 or M3 screw               | 10lb·in (1.1N·m)       |  |       |  |

**Diode Characteristics**

| Symbol           | Parameter                                 | Min.   | Typ. | Max. | Units | Conditions   |
|------------------|---|--|------|------|-------|--|
| I <sub>S</sub>   | Continuous Source Current<br>(Body Diode) | —  | —    | 6.8  | A     | MOSFET symbol showing the integral reverse p-n junction diode.       |
| I <sub>SM</sub>  | Pulsed Source Current<br>(Body Diode) ①   | —  | —    | 27   |       |  |
| V <sub>SD</sub>  | Diode Forward Voltage                     | —  | —    | 1.5  | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 6.8A, V <sub>GS</sub> = 0V ④ |
| t <sub>rr</sub>  | Reverse Recovery Time                     | —  | 85   | 130  | ns    | T <sub>J</sub> = 25°C, I <sub>F</sub> = 6.8A                         |
|                  |   | —  | 130  | 200  |       | T <sub>J</sub> = 125°C, di/dt = 100A/μs ④                            |
| Q <sub>rr</sub>  | Reverse Recovery Charge                   | —  | 280  | 420  | nC    | T <sub>J</sub> = 25°C, I <sub>S</sub> = 6.8A, V <sub>GS</sub> = 0V ④ |
|                  |   | —  | 570  | 860  |       | T <sub>J</sub> = 125°C, di/dt = 100A/μs ④                            |
| I <sub>RRM</sub> | Reverse Recovery Current                  | —  | 5.9  | 8.9  | A     | T <sub>J</sub> = 25°C  |
| t <sub>on</sub>  | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) |      |      |       |  |

# IRFIB7N50LPbF

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Rectifier

## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| Symbol  | Parameter                            | Min. | Typ. | Max. | Units               | Conditions  |
|---|--------------------------------------|------|------|------|---------------------|---|
| $V_{(\text{BR})\text{DSS}}$                   | Drain-to-Source Breakdown Voltage    | 500  | —    | —    | V                   | $V_{GS} = 0V, I_D = 250\mu\text{A}$                   |
| $\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.44 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$     |
| $R_{DS(\text{on})}$                           | Static Drain-to-Source On-Resistance | —    | 0.32 | 0.38 | $\Omega$            | $V_{GS} = 10V, I_D = 4.1\text{A}$ ④                   |
| $V_{GS(\text{th})}$                           | Gate Threshold Voltage               | 3.0  | —    | 5.0  | V                   | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$               |
| $I_{DSS}$                                     | Drain-to-Source Leakage Current      | —    | —    | 50   | $\mu\text{A}$       | $V_{DS} = 500V, V_{GS} = 0V$                          |
|   |                                      | —    | —    | 2.0  | mA                  | $V_{DS} = 400V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                                     | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                  | $V_{GS} = 30V$  |
|   | Gate-to-Source Reverse Leakage       | —    | —    | -100 | —                   | $V_{GS} = -30V$                                       |
| $R_G$   | Internal Gate Resistance             | —    | 0.88 | —    | $\Omega$            | f = 1MHz, open drain                                  |

## Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| Symbol                      | Parameter                                     | Min. | Typ. | Max. | Units | Conditions                                      |
|-----------------------------|---|------|------|------|-------|---|
| $g_{fs}$                    | Forward Transconductance                      | 4.7  | —    | —    | S     | $V_{DS} = 50V, I_D = 4.1\text{A}$               |
| $Q_g$                       | Total Gate Charge                             | —    | —    | 92   | nC    | $I_D = 6.8A$                                    |
| $Q_{gs}$                    | Gate-to-Source Charge                         | —    | —    | 24   | nC    | $V_{DS} = 400V$                                 |
| $Q_{gd}$                    | Gate-to-Drain ("Miller") Charge               | —    | —    | 44   | nC    | $V_{GS} = 10V, \text{See Fig. 7 \& 16}$ ④       |
| $t_{d(on)}$                 | Turn-On Delay Time                            | —    | 23   | —    | ns    | $V_{DD} = 250V$                                 |
| $t_r$                       | Rise Time                                     | —    | 36   | —    | ns    | $I_D = 6.8A$                                    |
| $t_{d(off)}$                | Turn-Off Delay Time                           | —    | 47   | —    | ns    | $R_G = 9.0\Omega$                               |
| $t_f$                       | Fall Time                                     | —    | 19   | —    | ns    | $V_{GS} = 10V, \text{See Fig. 11a \& 11b}$ ④    |
| $C_{iss}$                   | Input Capacitance                             | —    | 2220 | —    | pF    | $V_{GS} = 0V$                                   |
| $C_{oss}$                   | Output Capacitance                            | —    | 230  | —    | pF    | $V_{DS} = 25V$                                  |
| $C_{rss}$                   | Reverse Transfer Capacitance                  | —    | 23   | —    | pF    | $f = 1.0\text{MHz, See Fig. 5}$                 |
| $C_{oss}$                   | Output Capacitance                            | —    | 2780 | —    | pF    | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$ |
| $C_{oss}$                   | Output Capacitance                            | —    | 63   | —    | pF    | $V_{GS} = 0V, V_{DS} = 400V, f = 1.0\text{MHz}$ |
| $C_{oss \text{ eff.}}$      | Effective Output Capacitance                  | —    | 140  | —    | —     | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$ ⑤   |
| $C_{oss \text{ eff. (ER)}}$ | Effective Output Capacitance (Energy Related) | —    | 100  | —    | —     | —   |

## Avalanche Characteristics

| Symbol   | Parameter                       | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy ② | —    | 550  | mJ    |
| $I_{AR}$ | Avalanche Current ①             | —    | 6.8  | A     |
| $E_{AR}$ | Repetitive Avalanche Energy ①   | —    | 4.6  | mJ    |

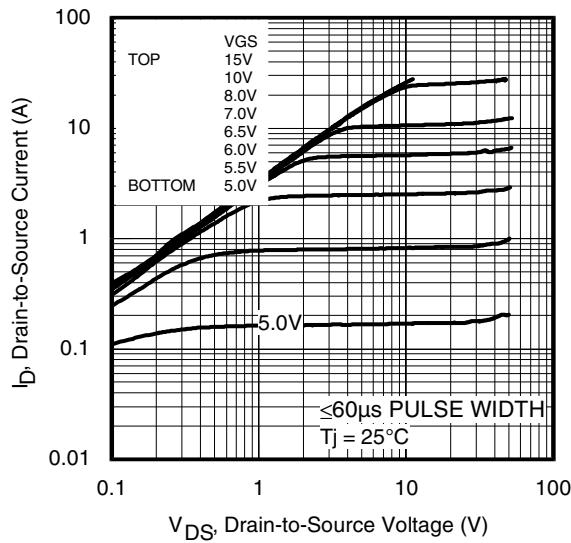
## Thermal Resistance

| Symbol                | Parameter           | Typ. | Max. | Units |
|-----------------------|---------------------|------|------|-------|
| $R_{\theta\text{JC}}$ | Junction-to-Case    | —    | 2.69 | °C/W  |
| $R_{\theta\text{JA}}$ | Junction-to-Ambient | —    | 65   | —     |

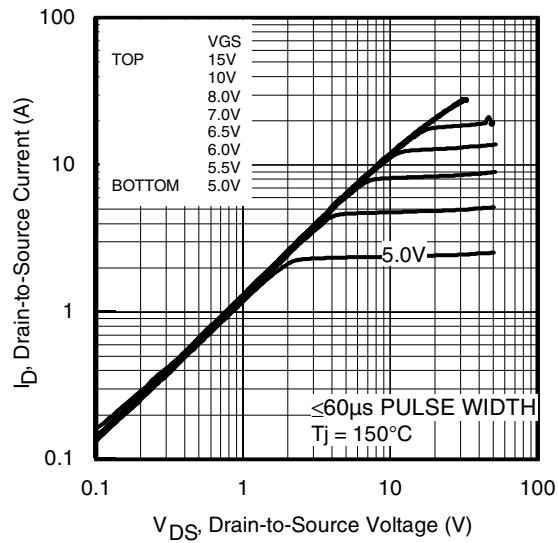
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See Fig. 12).
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 24\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 6.8\text{A}$ , (See Figure 14).
- ③  $I_{SD} \leq 6.8$ ,  $di/dt \leq 650\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $dv/dt = 24\text{V/ns}$ ,  $T_J \leq 150^\circ\text{C}$ .
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss \text{ eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .  $C_{oss \text{ eff. (ER)}}$  is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

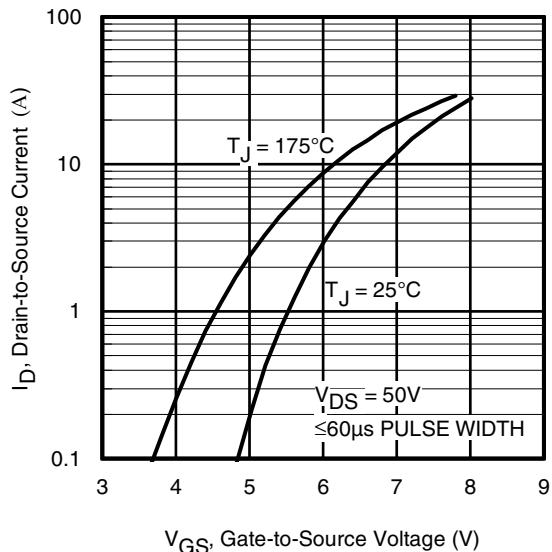
# IRFIB7N50LPbF



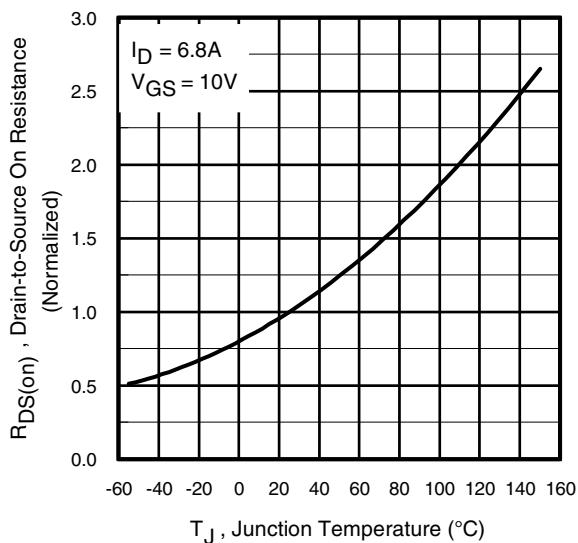
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



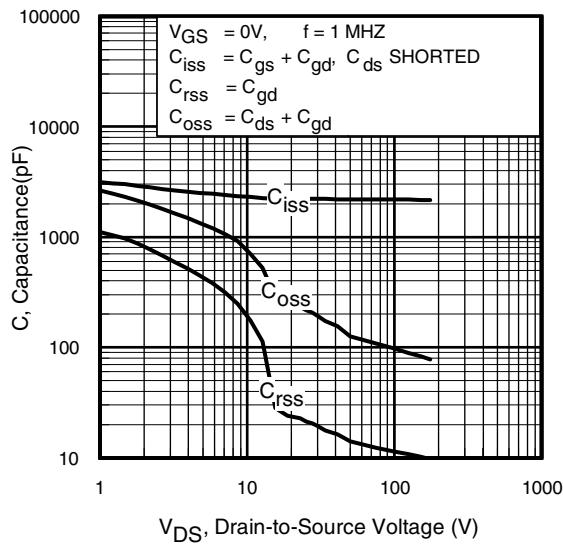
**Fig 3.** Typical Transfer Characteristics



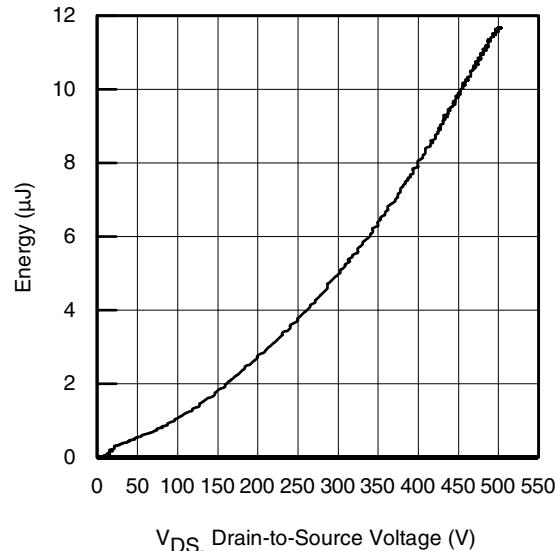
**Fig 4.** Normalized On-Resistance  
vs. Temperature

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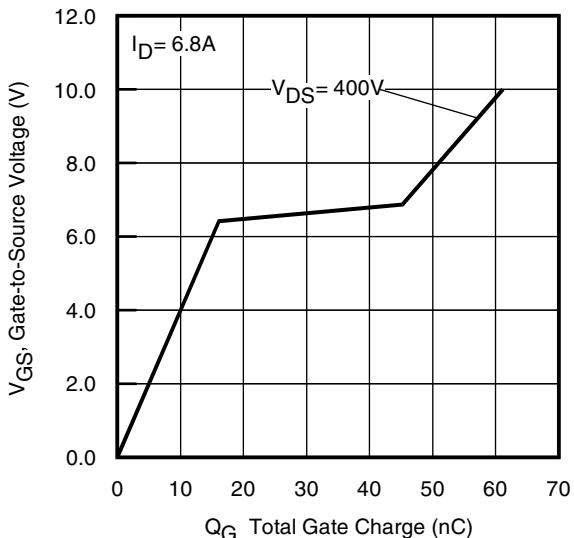
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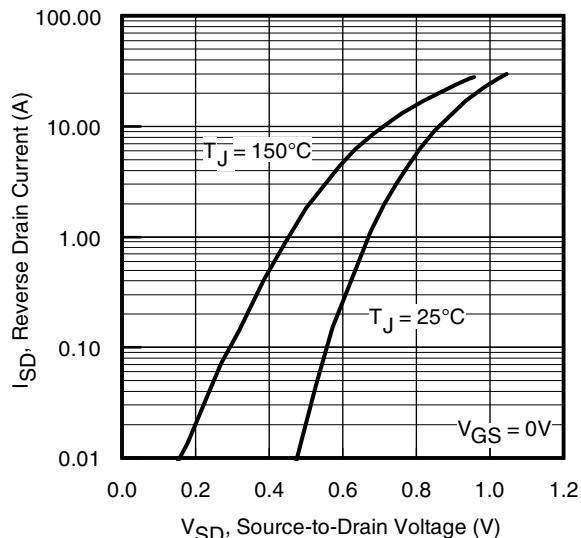
**Fig 5.** Typical Capacitance vs.  
Drain-to-Source Voltage



**Fig 6.** Typ. Output Capacitance  
Stored Energy vs.  $V_{DS}$



**Fig 7.** Typical Gate Charge vs.  
Gate-to-Source Voltage



**Fig 8.** Typical Source-Drain Diode  
Forward Voltage

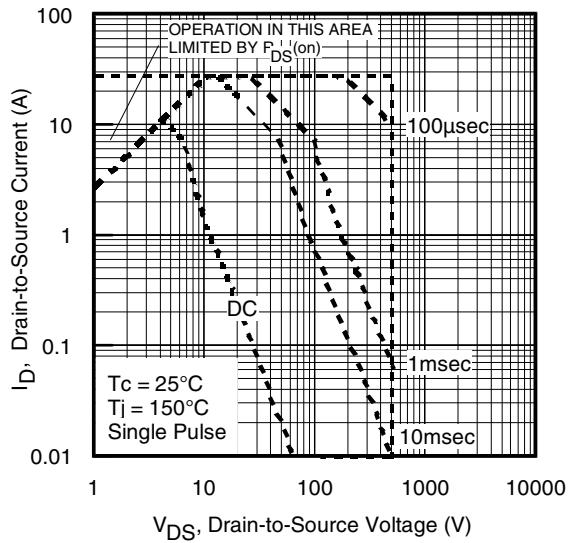


Fig 9. Maximum Safe Operating Area

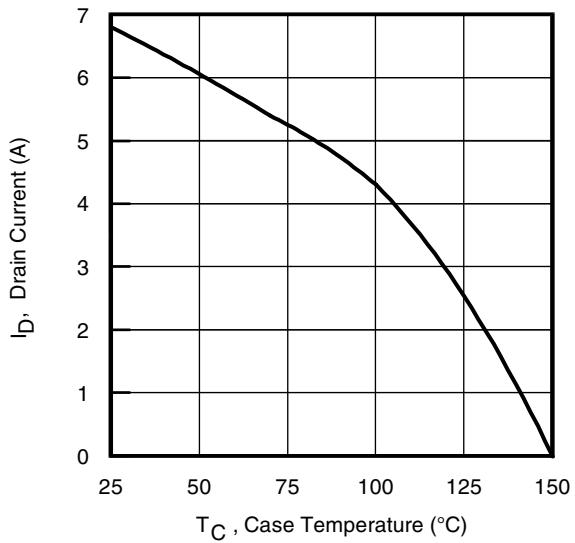


Fig 10. Maximum Drain Current vs.  
Case Temperature

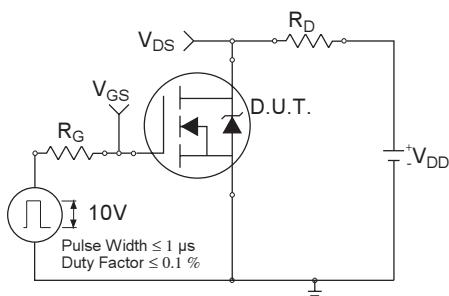


Fig 11a. Switching Time Test Circuit

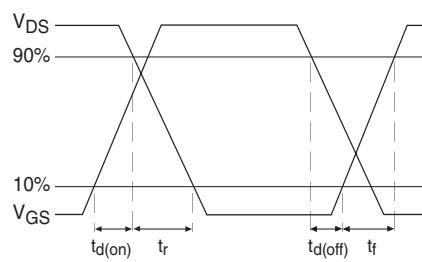


Fig 11b. Switching Time Waveforms

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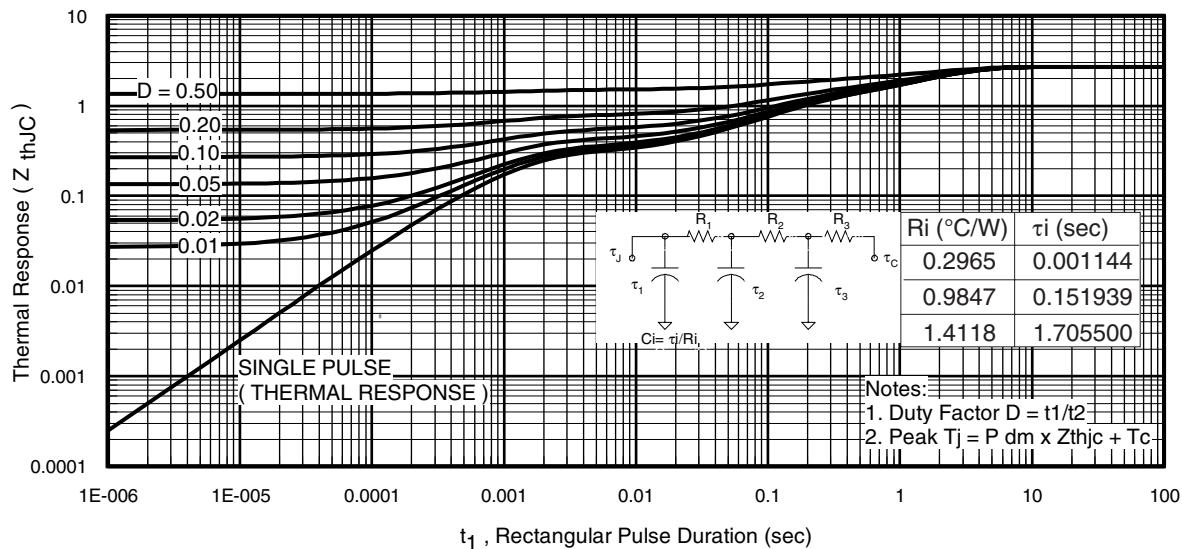


Fig 12. Maximum Effective Transient Thermal Impedance, Junction-to-Case

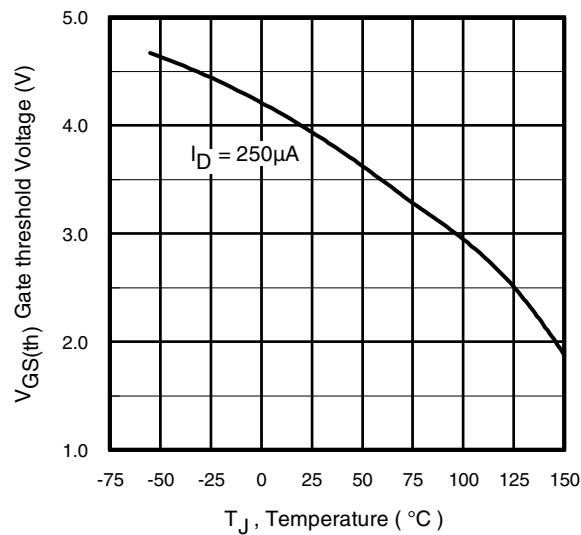
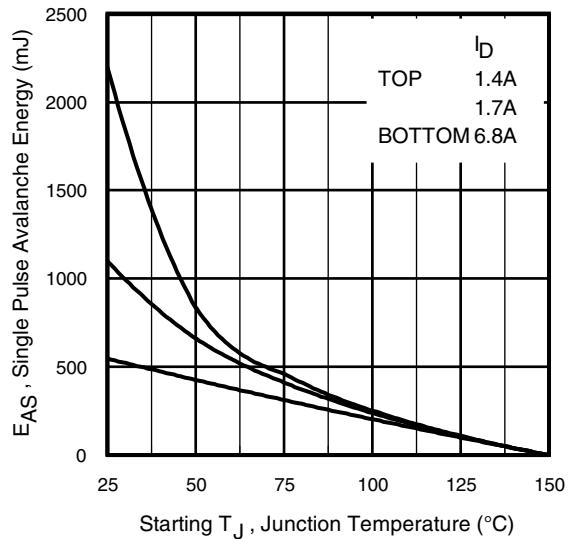
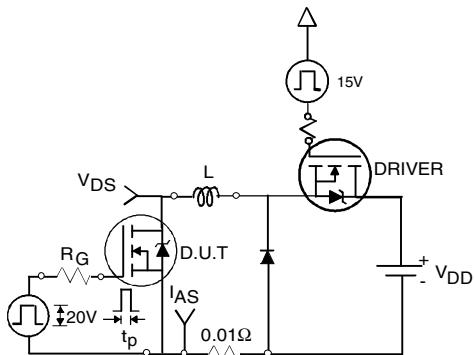


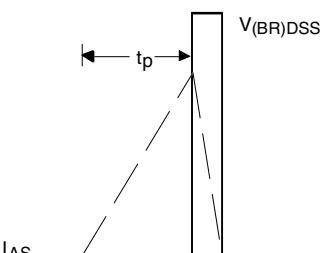
Fig 13. Threshold Voltage vs. Temperature



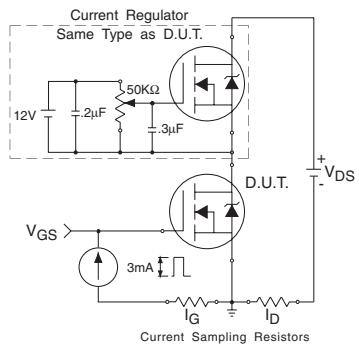
**Fig 14.** Maximum Avalanche Energy  
vs. Drain Current



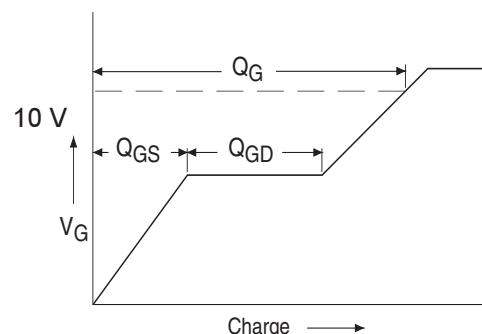
**Fig 15a.** Unclamped Inductive Test Circuit



**Fig 15b.** Unclamped Inductive Waveforms

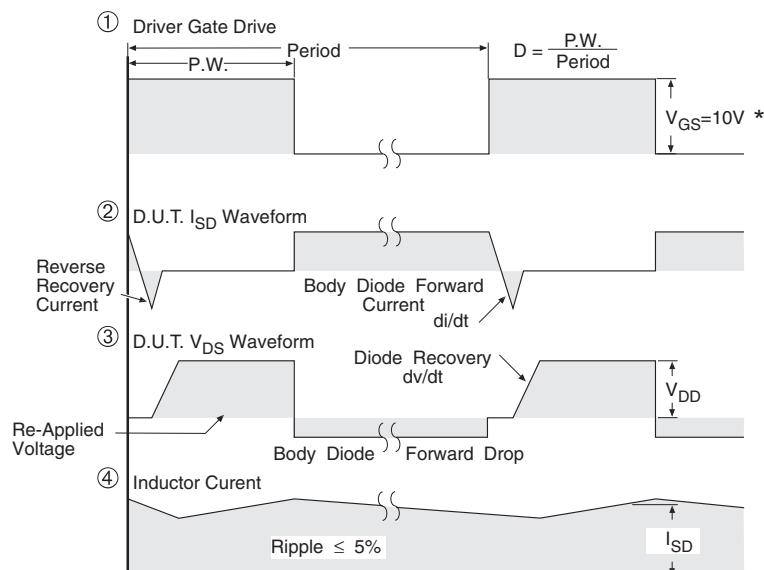
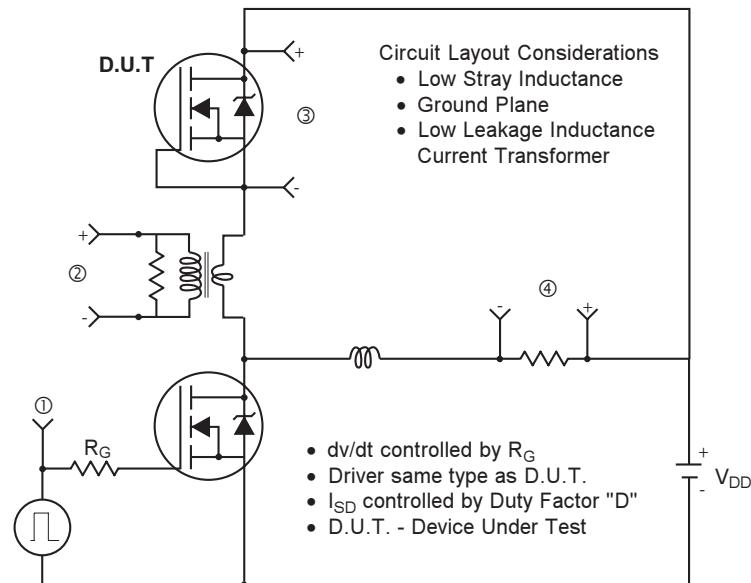


**Fig 16a.** Gate Charge Test Circuit



**Fig 16b.** Basic Gate Charge Waveform

## Peak Diode Recovery dv/dt Test Circuit



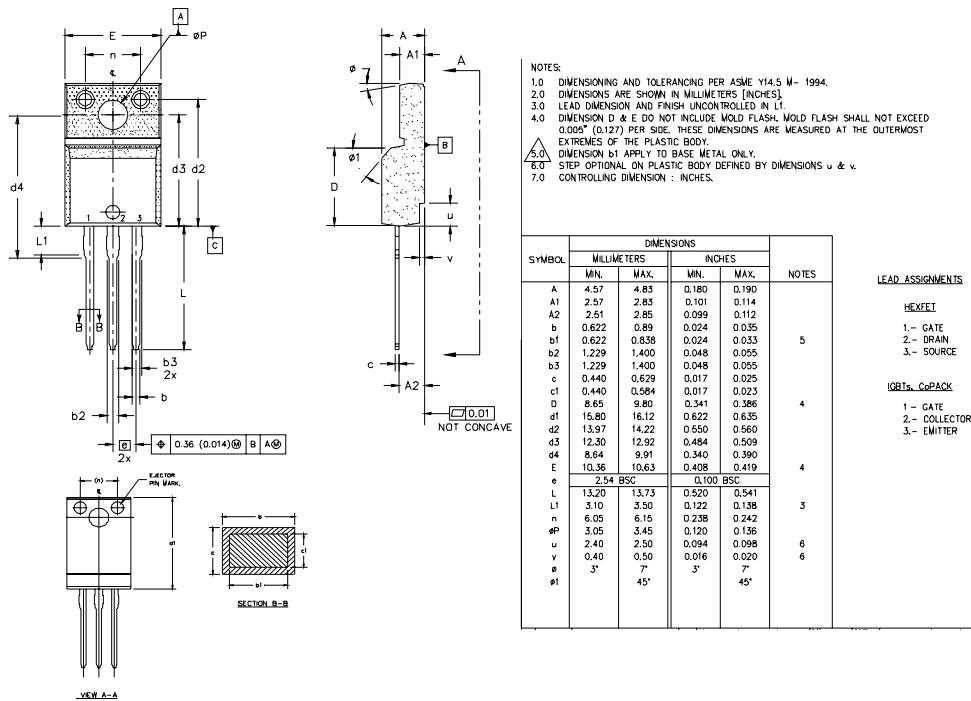
\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 17.** For N-Channel HEXFET® Power MOSFETs

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## TO-220 Full-Pak Package Outline

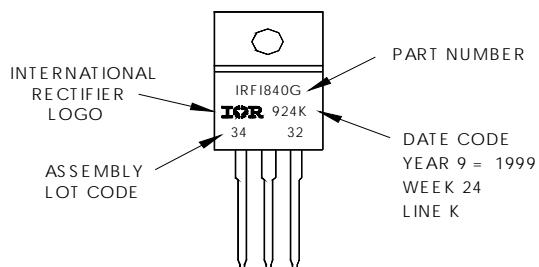
Dimensions are shown in millimeters (inches)



## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G  
WITH ASSEMBLY  
LOT CODE 3432  
ASSEMBLED ON WW 24 1999  
IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line  
position indicates "Lead-Free"



**TO-220AB FullPak package is not recommended for Surface Mount Application.**

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

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**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903  
08/04



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